

**Search Notes**

Application/Control No.

10/604,796

Examiner

Hashem Farrokh

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
711	167	1/19/2005	HF
710	57	1/19/2005	HF

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM and East Inventor Search conducted	1/20/2006	HF
IEEE Xplore Search conducted	1/20/2006	HF
Nasser Moazzami Consulted	1/19/2006	HF
EAST (PGPUB,USPAT,USOCR,EPO,JPO,D, ERWENT,IBM_TDB)	1/19/2006	HF
711/1-3,101-105,111-115,167; 712/1,38,43 (Text Search updated)	1/20/2006	HF
711/ALL; 370/235,328,382,386,389,392,400,46 6 Text Search see East Prinou	1/19/2006	HF
710/57-60 (Text Search see Printout)	1/19/2006	HF